

IRF9240

PD-90420B

Repetitive Avalanche and dv/dt Rated Power MOSFET Thru-Hole (TO-204AA) -200V, -11A, P-channel

Features

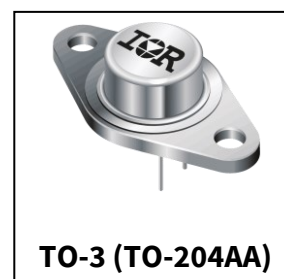
- Repetitive avalanche ratings
- Dynamic dv/dt rating
- Hermetically sealed
- Simple drive requirements
- ESD rating: Class 2 per MIL-STD-750, Method 1020

Potential Applications

- DC-DC converter
- Motor drives

Product Summary

- BV_{DSS} : -200V
- I_D : -11A
- $R_{DS(on),max}$: 0.5Ω
- $Q_{G,max}$: 60nC



Product Validation

Adhered to JANTX screening flow according to MIL-PRF-19500 for high-reliability applications

Description

HEXFET POWER MOSFET technology is the key to IR HiRel advanced line of power MOSFET transistors. The efficient geometry and unique processing of this latest “State of the Art” design achieves: very low on-state resistance combined with high transconductance; superior reverse energy and diode recovery dv/dt capability. The HEXFET transistors also feature all of the well-established advantages of MOSFETs such as voltage control, very fast switching and temperature stability of the electrical parameters. They are well suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers and high energy pulse circuits.

Ordering Information

Table 1 Ordering options

Part number	Package	Screening Level
IRF9240	TO-3 (TO-204AA)	COTS
IRF9240SCX	TO-3 (TO-204AA)	JANTX

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Power MOSFET Thru-Hole (TO-204AA)

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Absolute Maximum Ratings

1 Absolute Maximum Ratings

Table 2 Absolute Maximum Ratings

Symbol	Parameter	Value	Unit
$I_{D1} @ V_{GS} = -10V, T_C = 25^{\circ}C$	Continuous Drain Current	-11	A
$I_{D2} @ V_{GS} = -10V, T_C = 100^{\circ}C$	Continuous Drain Current	-7.0	A
$I_{DM} @ T_C = 25^{\circ}C$	Pulsed Drain Current ¹	-44	A
$P_D @ T_C = 25^{\circ}C$	Maximum Power Dissipation	125	W
	Linear Derating Factor	1.0	W/ $^{\circ}C$
V_{GS}	Gate-to-Source Voltage	± 20	V
E_{AS}	Single Pulse Avalanche Energy ²	500	mJ
I_{AR}	Avalanche Current ¹	-11	A
E_{AR}	Repetitive Avalanche Energy ¹	12.5	mJ
dv/dt	Peak Diode Reverse Recovery ³	-5.0	V/ns
T_J T_{STG}	Operating Junction and Storage Temperature Range	-55 to +150	$^{\circ}C$
	Lead Temperature	300 (0.063 in. (1.6mm) from case for 10s)	
	Weight	11.5 (Typical)	

¹ Repetitive Rating; Pulse width limited by maximum junction temperature.² $V_{DD} = -50V$, starting $T_J = 25^{\circ}C$, $L = 8.26mH$, Peak $I_L = -11A$, $V_{GS} = -10V$ ³ $I_{SD} \leq -11A$, $di/dt \leq -150A/\mu s$, $V_{DD} \leq -200V$, $T_J \leq 150^{\circ}C$

Device Characteristics

2 Device Characteristics

2.1 Electrical Characteristics

Table 3 Static and Dynamic Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (Unless Otherwise Specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
BV_{DSS}	Drain-to-Source Breakdown Voltage	-200	—	—	V	$V_{GS} = 0V, I_D = -1.0mA$
$\Delta BV_{DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	-0.20	—	V/ $^\circ\text{C}$	Reference to 25°C , $I_D = -1.0mA$
$R_{DS(on)}$	Static Drain-to-Source On-State Resistance	—	—	0.50	Ω	$V_{GS} = -10V, I_{D2} = -7.0A^1$
		—	—	0.58		$V_{GS} = -10V, I_{D2} = -11A^1$
$V_{GS(th)}$	Gate Threshold Voltage	-2.0	—	-4.0	V	$V_{DS} = V_{GS}, I_D = -250\mu A$
G_{fs}	Forward Transconductance	4.0	—	—	S	$V_{DS} = -15V, I_{D2} = -7.0A^1$
I_{DSS}	Zero Gate Voltage Drain Current	—	—	-25	μA	$V_{DS} = -160V, V_{GS} = 0V$
		—	—	-250		$V_{DS} = -160V, V_{GS} = 0V, T_J = 125^\circ\text{C}$
I_{GSS}	Gate-to-Source Leakage Forward	—	—	-100	nA	$V_{GS} = -20V$
	Gate-to-Source Leakage Reverse	—	—	100		$V_{GS} = 20V$
Q_G	Total Gate Charge	28	—	60	nC	$I_{D1} = -11A$
Q_{GS}	Gate-to-Source Charge	3.0	—	15		$V_{DS} = -100V$
Q_{GD}	Gate-to-Drain ('Miller') Charge	4.5	—	38		$V_{GS} = -10V$
$t_{d(on)}$	Turn-On Delay Time	—	—	35	ns	$I_{D1} = -11A^{**}$ $V_{DD} = -100V$ $R_G = 9.1\Omega$ $V_{GS} = -10V$
t_r	Rise Time	—	—	85		
$t_{d(off)}$	Turn-Off Delay Time	—	—	85		
t_f	Fall Time	—	—	65		
$L_s + L_D$	Total Inductance	—	6.1	—	nH	Measured from Drain lead (6mm/0.25 in from package) to Source lead (6mm/0.25 in from package)
C_{iss}	Input Capacitance	—	1200	—	pF	$V_{GS} = 0V$
C_{oss}	Output Capacitance	—	570	—		$V_{DS} = -25V$
C_{rss}	Reverse Transfer Capacitance	—	81	—		$f = 1.0MHz$

** Switching speed maximum limits are based on manufacturing test equipment and capability.

¹ Pulse width $\leq 300 \mu s$; Duty Cycle $\leq 2\%$

Device Characteristics

2.2 Source-Drain Diode Ratings and Characteristics

Table 4 Source-Drain Diode Characteristics

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
I _S	Continuous Source Current (Body Diode)	—	—	-11	A	
I _{SM}	Pulsed Source Current (Body Diode) ¹	—	—	-44	A	
V _{SD}	Diode Forward Voltage	—	—	-4.6	V	T _J = 25°C, I _S = -11A, V _{GS} = 0V ²
t _{rr}	Reverse Recovery Time	—	270	440	ns	T _J = 25°C, I _F = -11A, V _{DD} ≤ -50V di/dt = -100A/μs ²
Q _{rr}	Reverse Recovery Charge	—	4.8	—	μC	
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D)				

2.3 Thermal Characteristics

Table 5 Thermal Resistance

Symbol	Parameter	Min.	Typ.	Max.	Unit
$R_{\theta JC}$	Junction-to-Case	—	—	1.0	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Junction-to-Ambient (Typical socket mount)	—	—	30	

¹ Repetitive Rating; Pulse width limited by maximum junction temperature.

² Pulse width $\leq 300\ \mu\text{s}$; Duty Cycle $\leq 2\%$

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Electrical Characteristics Curves

3 Electrical Characteristics Curves

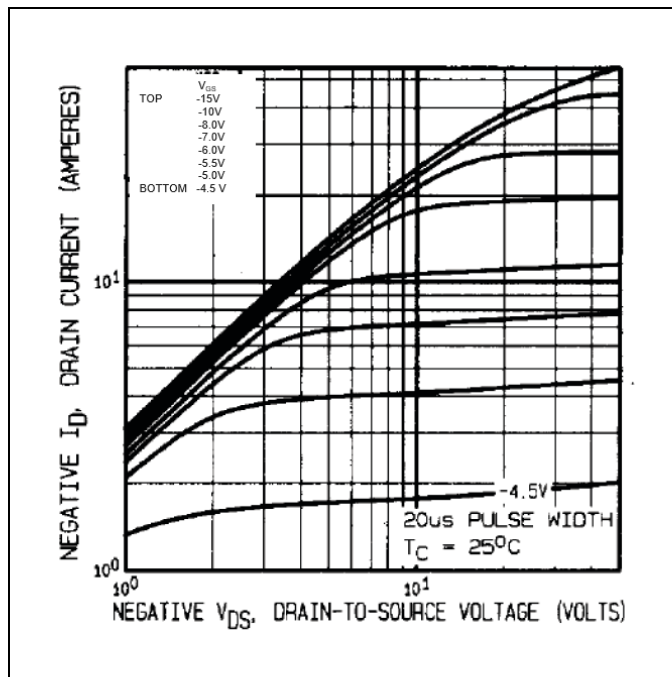


Figure 1 Typical Output Characteristics

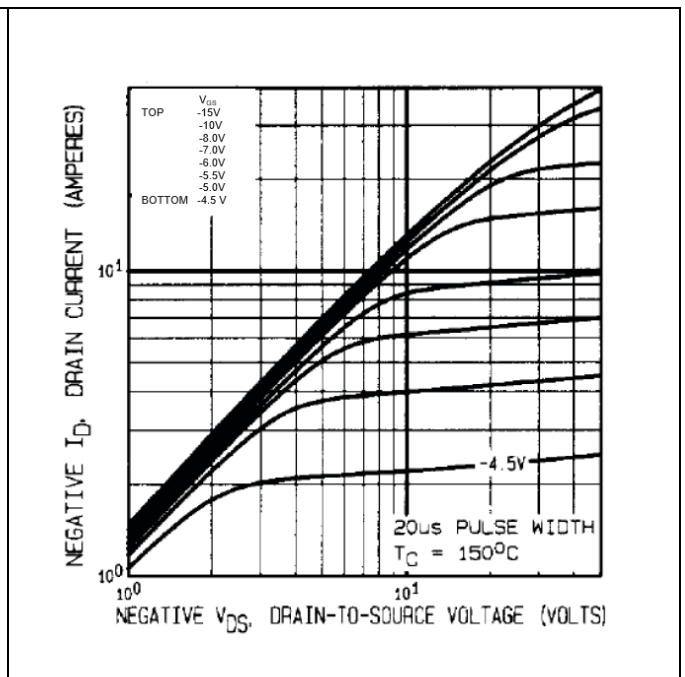


Figure 2 Typical Output Characteristics

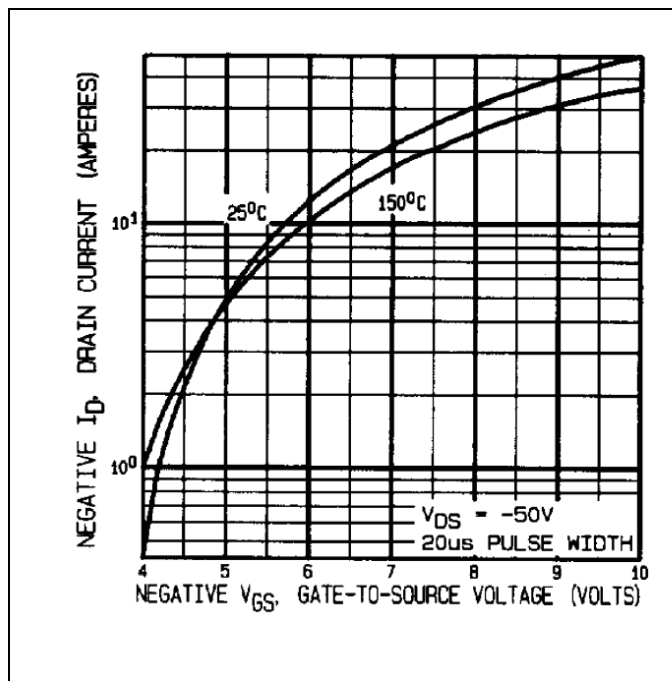


Figure 3 Typical Transfer Characteristics

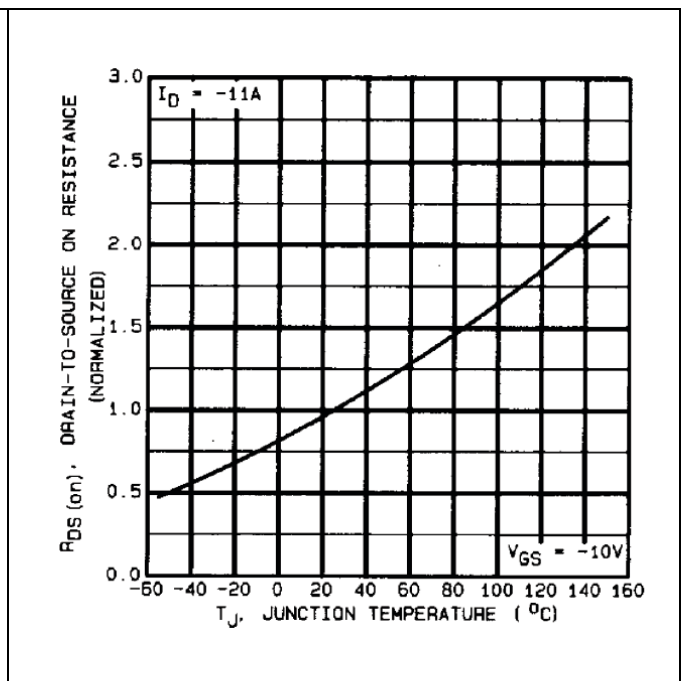


Figure 4 Normalized On-Resistance Vs. Temperature

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Electrical Characteristics Curves

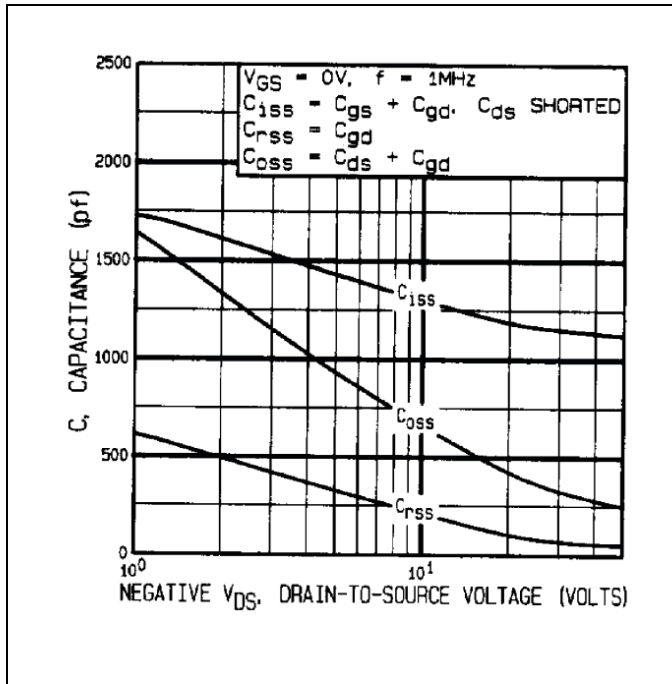


Figure 5 Typical Capacitance Vs. Drain-to-Source Voltage

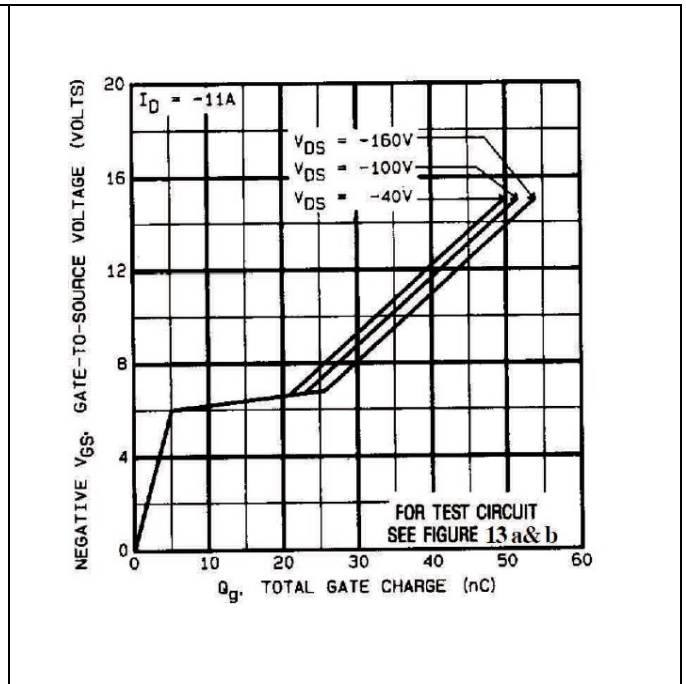


Figure 6 Typical Gate Charge Vs. Gate-to-Source Voltage

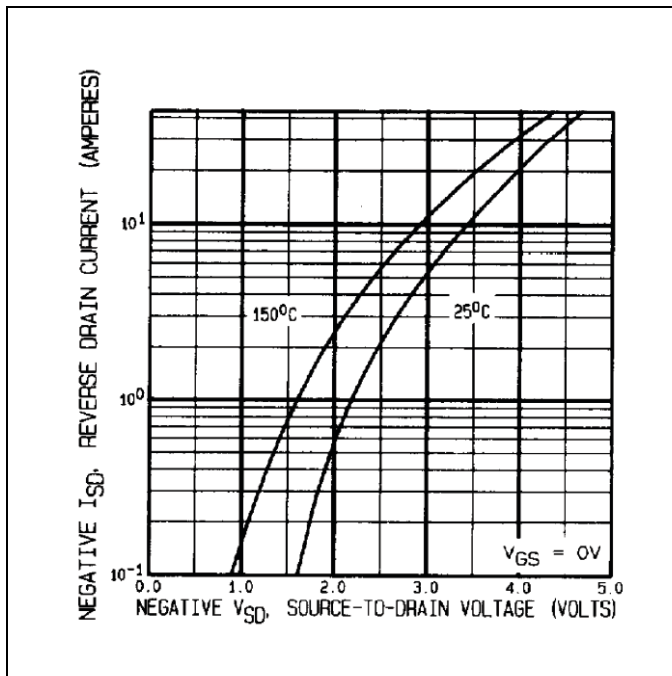


Figure 7 Typical Source-Drain Diode Forward Voltage

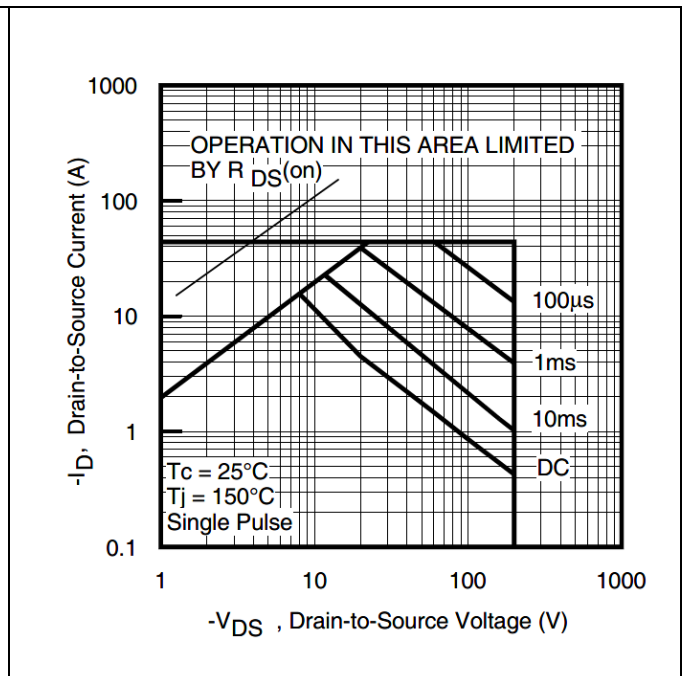


Figure 8 Maximum Safe Operating Area

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Electrical Characteristics Curves

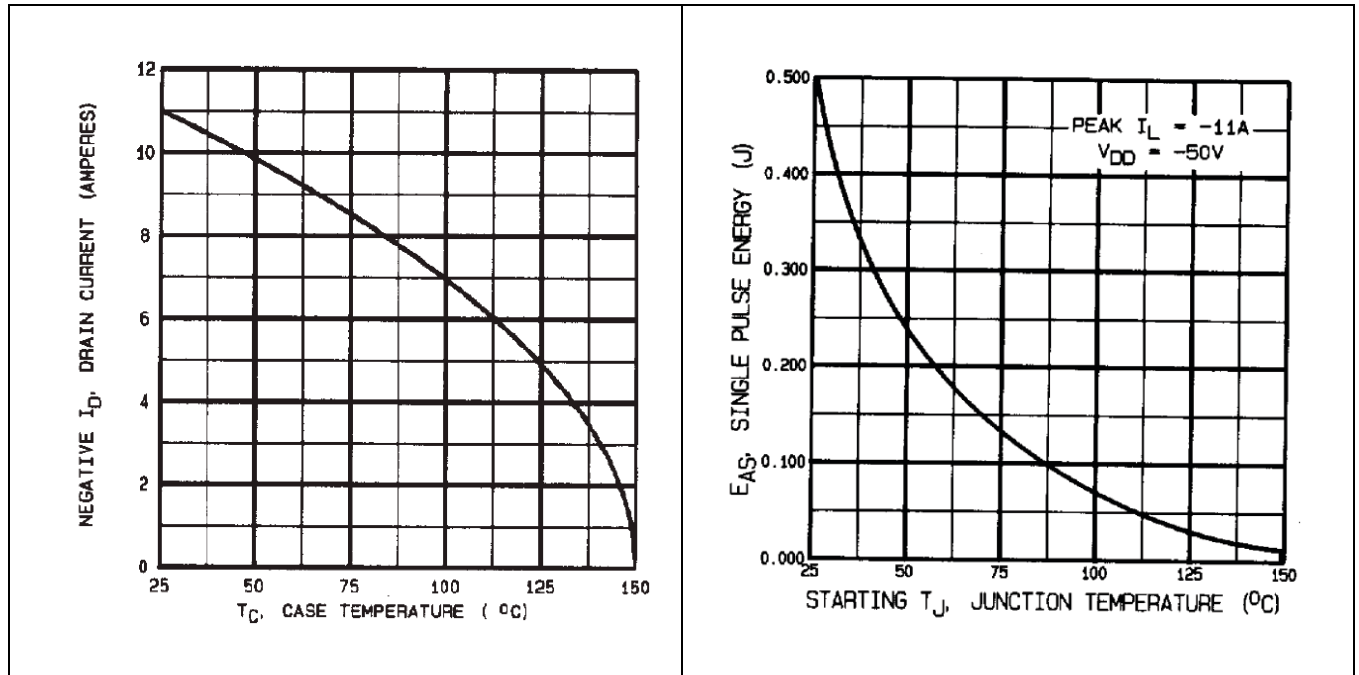


Figure 9 Maximum Drain Current Vs. Case Temperature

Figure 10 Maximum Avalanche Energy Vs. Junction Temperature

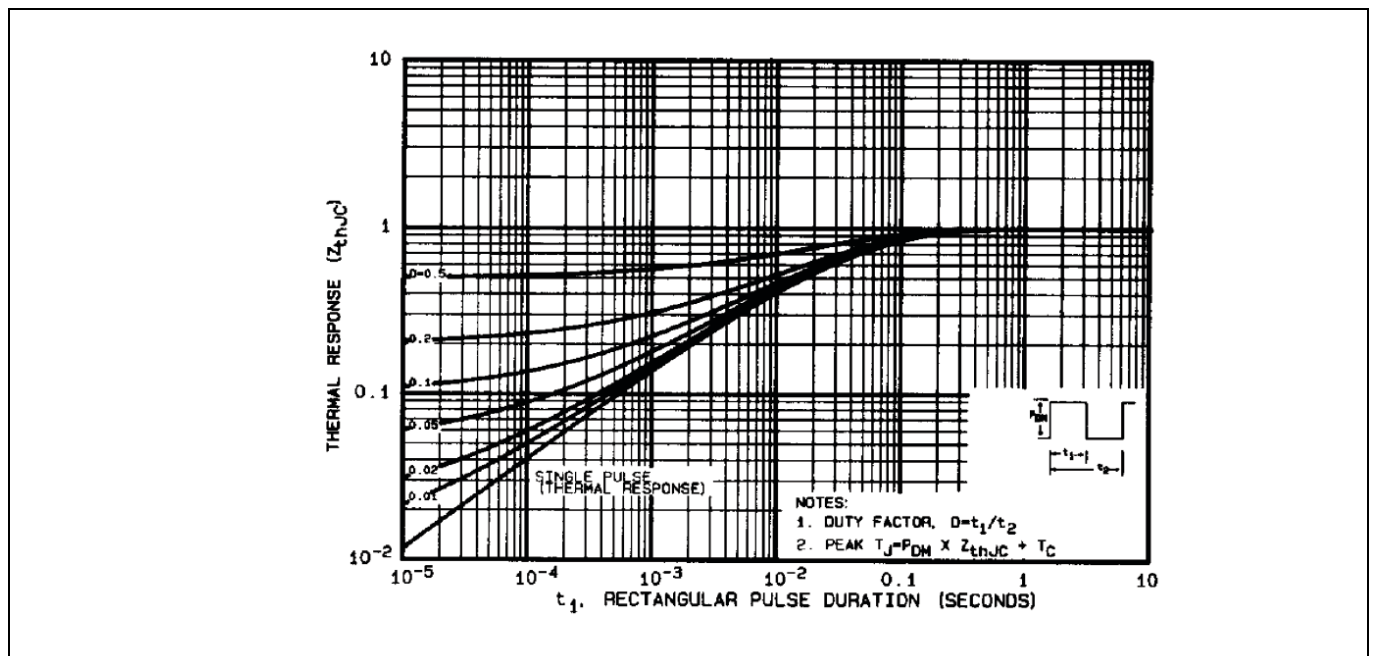


Figure 11 Maximum Effective Transient Thermal Impedance, Junction-to-Case

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Test Circuits

4 Test Circuits

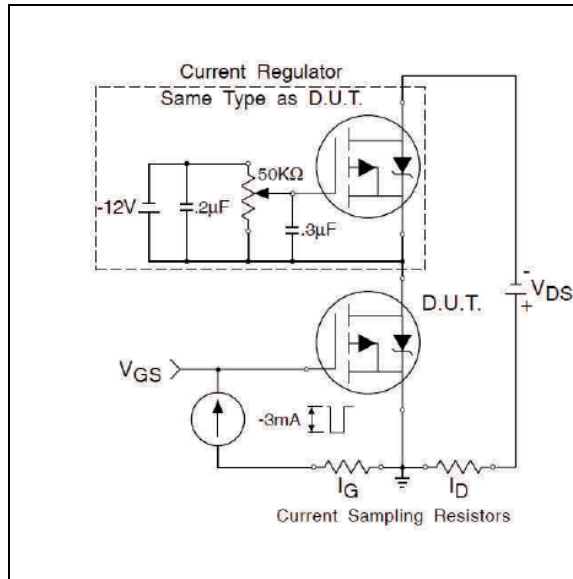


Figure 12 Gate Charge Test Circuit

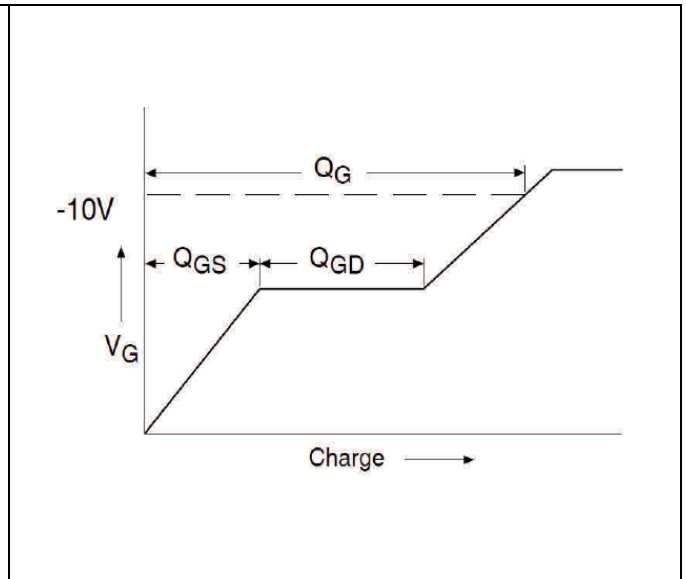


Figure 13 Gate Charge Waveform

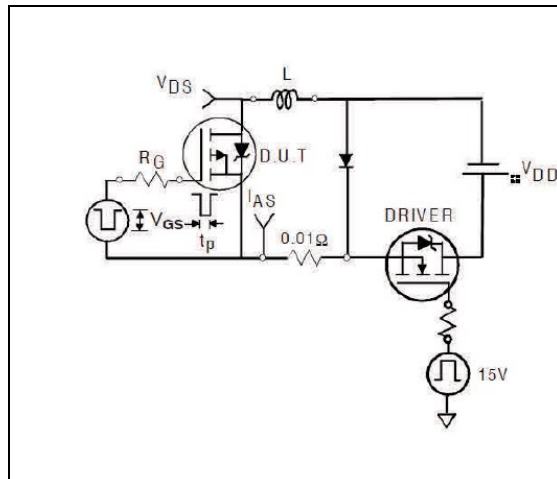


Figure 14 Unclamped Inductive Test Circuit

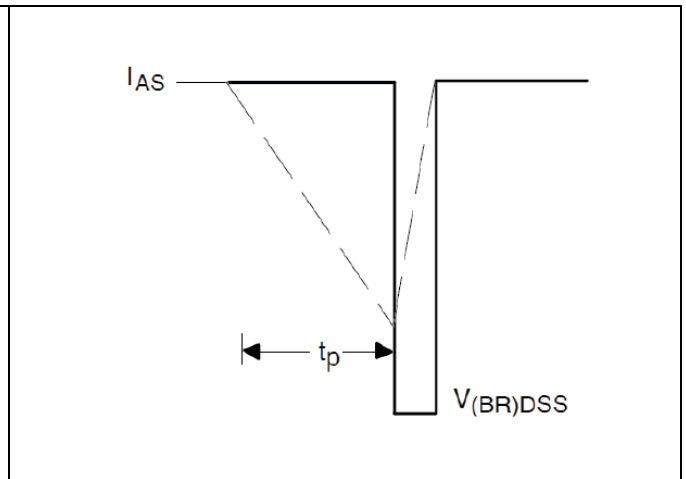


Figure 15 Unclamped Inductive Waveform

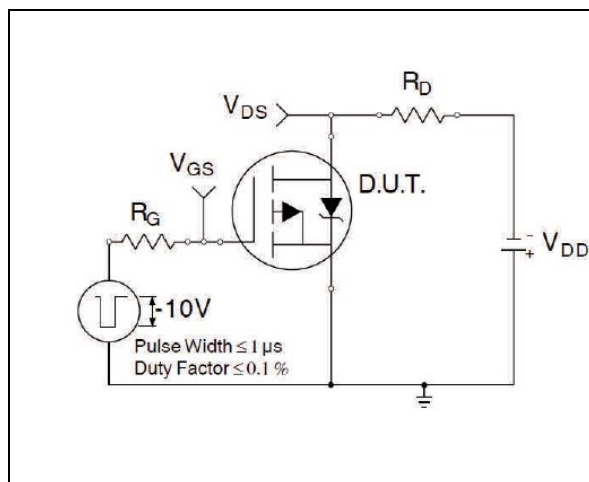


Figure 16 Switching Time Test Circuit

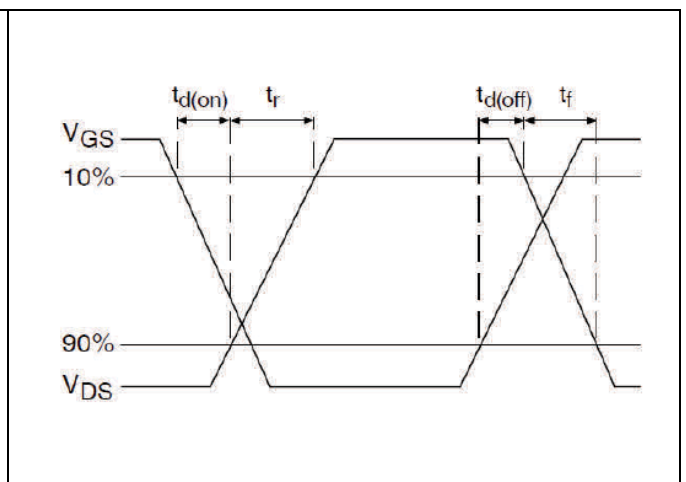


Figure 17 Switching Time Waveforms

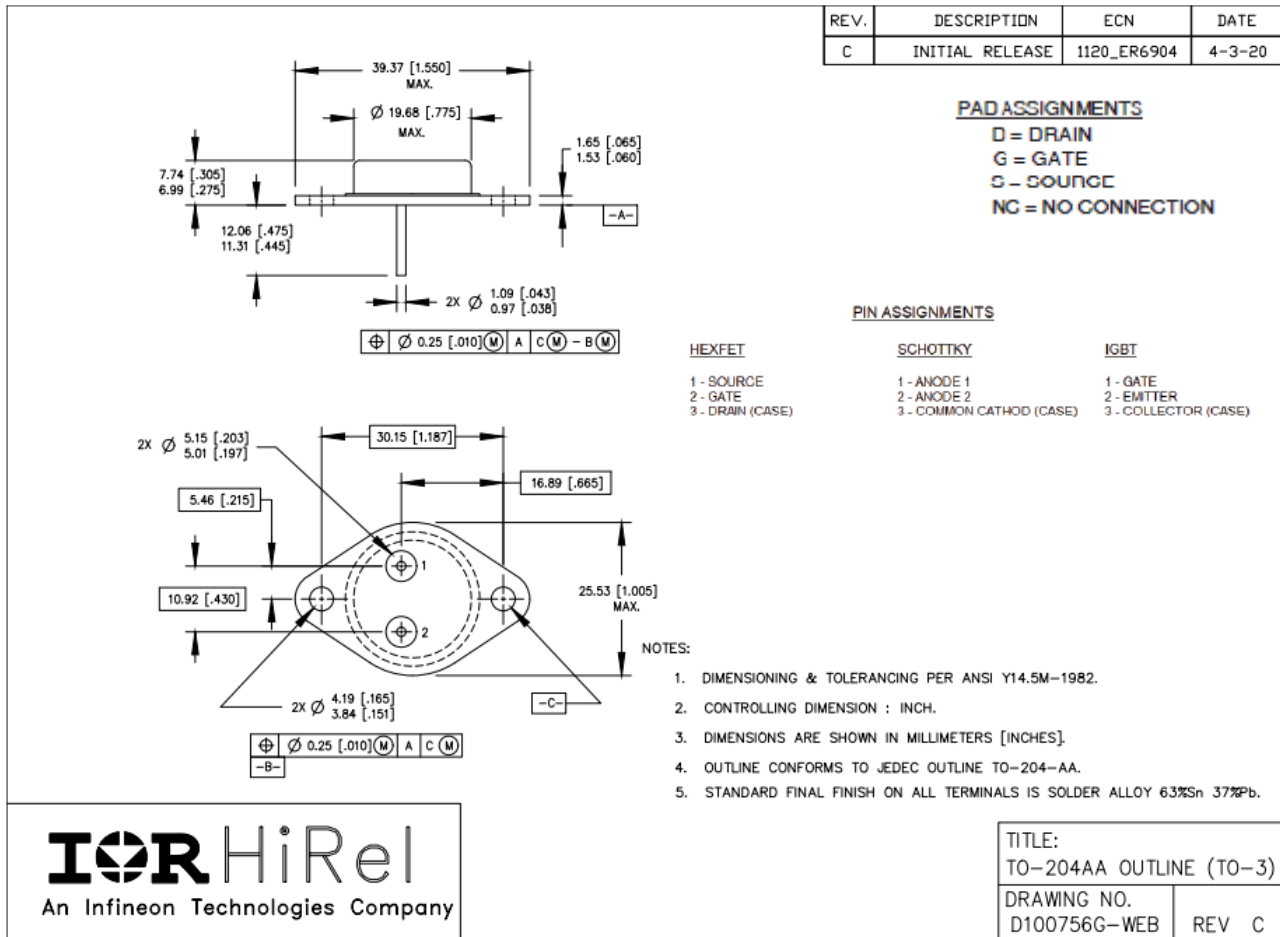
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Package Outline

5 Package Outline

Note: For the most updated package outline, please see the website: [TO-3 \(TO-204AA\)](https://www.infineon.com/products/mosfet/to-204aa)



IRF9240**Power MOSFET Thru-Hole (TO-204AA)****Revision history****Revision history**

Document version	Date of release	Description of changes
	01/26/2001	Datasheet (PD-90420)
Rev A	07/08/2019	Updated based on ECN-1120_06844
Rev B	12/06/2024	Updated based on ECN-1120_10102

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